Integrated Circuit Systems, Inc.

ICS83052I

2:1, Single-Ended Multiplexer

GENERAL DESCRIPTION



The ICS83052I is a low skew, 2:1, Single-ended Multiplexer and a member of the HiPerClockS[™] family of High Performance Clock Solutions from ICS. The ICS83052I has two selectable single-ended clock inputs and one single-ended clock

output. The output has a $V_{\rm DDO}$ pin which may be set at 3.3V, 2.5V, or 1.8V, making the device ideal for use in voltage translation applications. An output enable pin places the output in a high impedance state which may be useful for testing or debug. The device operates up to 250MHz and is packaged in an 8 TSSOP.

FEATURES

• 2:1 single-ended multiplexer

• Q0 nominal output impedance: $15\Omega (V_{DDO} = 3.3V)$

· Maximum output frequency: 250MHz

• Propagation delay: 2.5ns (typical)

• Input skew: 45ps (typical)

Part-to-part skew: TBD

• Additive phase jitter, RMS (12KHz - 20MHz):

0.07ps (typical)

· Operating supply modes:

 V_{DD}/V_{DDO}

3.3V/3.3V

3.3V/2.5V

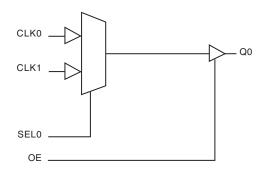
3.3V/1.8V

2.5V/2.5V

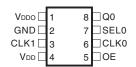
2.5V/1.8V

• -40°C to 85°C ambient operating temperature

BLOCK DIAGRAM



PIN ASSIGNMENT



ICS83052I

8-Lead TSSOP 4.40mm x 3.0mm x 0.925mm package body

G Package Top View

The Preliminary Information presented herein represents a product in prototyping or pre-production. The noted characteristics are based on initial product characterization. Integrated Circuit Systems, Incorporated (ICS) reserves the right to change any circuitry or specifications without notice.

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TABLE 1. PIN DESCRIPTIONS

Number	Name	Туре		Description
1	V _{DDO}	Power		Output supply pin.
2	GND	Power		Power supply ground.
3, 6	CLK1, CLK0	Input	Pulldown	Single-ended clock inputs. LVCMOS/LVTTL interface levels.
4	V _{DD}	Power		Core supply pin.
5	OE	Input	Pullup	Output enable. When LOW, outputs are in HIGH impedance state. When HIGH, outputs are active. LVCMOS / LVTTL interface levels.
7	SEL0	Input	Pulldown	Clock select input. See Control Input Function Table. LVCMOS / LVTTL interface levels.
8	Q0	Output		Single-ended clock output. LVCMOS/LVTTL interface levels.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input Pullup Resistor			51		ΚΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		ΚΩ
C _{PD}	Power Dissipation Capacitance (per output)			11		рF
R _{out}	Output Impedance			15		Ω

TABLE 3. CONTROL INPUT FUNCTION TABLE

Control Inputs	Input Selected to Q0	
SEL0	Input Selected to QU	
0	CLK0	
1	CLK1	

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ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD} 4.6V

Inputs, V_{I} -0.5V to V_{DD} + 0.5 V

Outputs, V_{O} -0.5V to $V_{DDO} + 0.5V$

Package Thermal Impedance, θ₁₄ 101.7°C/W (0 mps)

Storage Temperature, T_{STG} -65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Table 4A. Power Supply DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $V_{DDO} = 3.3V \pm 5\%$, $2.5V \pm 5\%$ or $1.8V \pm 0.2V$, $T_A = -40^{\circ}\text{C}$ to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		3.135	3.3	3.465	V
			3.135	3.3	3.465	V
V _{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
			1.6	1.8	2.0	V
I _{DD}	Power Supply Current			32		mA
I _{DDO}	Output Supply Current			4		mA

Table 4B. Power Supply DC Characteristics, $V_{DD} = 2.5V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$ or $1.8V \pm 0.2V$, Ta = -40°C to 85° C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		2.375	2.5	2.625	V
V	Output Cumply Voltage		2.375	2.5	2.625	V
V _{DDO}	Output Supply Voltage		1.6	1.8	2.0	V
I _{DD}	Power Supply Current			30		μΑ
I _{DDO}	Output Supply Current			4		μΑ

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TABLE 4C. LVCMOS/LVTTL DC CHARACTERISTICS, TA = -40°C TO 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
		CLK0, CLK1	$V_{DD} = 3.3V \pm 5\%$	2		V _{DD} + 0.3	V
V	Input High Voltage	CLRO, CLRT	$V_{DD} = 2.5V \pm 5\%$	1.7		$V_{DD} + 0.3$	V
V _{IH}	Imput riigir voitage	OE, SEL0	$V_{DD} = 3.3V \pm 5\%$	2		$V_{DD} + 0.3$	V
		OL, SELO	$V_{DD} = 2.5V \pm 5\%$	1.7		$V_{DD} + 0.3$	V
		CI KU CI K1	$V_{DD} = 3.3V \pm 5\%$	-0.3		1.3	V
V	CLK0, CLK1 $V_{DD} = 2.5V \pm 5\%$	$V_{DD} = 2.5V \pm 5\%$	-0.3		0.7	V	
V _{IL}	Input Low Voltage	OE, SEL0	$V_{DD} = 3.3V \pm 5\%$	-0.3		1.3	V
		OE, SELU	$V_{DD} = 2.5V \pm 5\%$	-0.3		0.7	٧
I _{IH}	Input High Current	CLK0, CLK1, SEL0	$V_{DD} = 3.3V \text{ or } 2.5V \pm 5\%$			150	μΑ
III		OE	$V_{DD} = 3.3V \text{ or } 2.5V \pm 5\%$			5	μΑ
I	Input Low Current	CLK0, CLK1, SEL0	$V_{DD} = 3.3V \text{ or } 2.5V \pm 5\%$	-5			μA
IL		OE	$V_{DD} = 3.3V \text{ or } 2.5V \pm 5\%$	-150			μΑ
			$V_{DDO} = 3.3V \pm 5\%$; NOTE 1	2.6			V
V _{OH}	Output HighVoltage		$V_{DDO} = 2.5V \pm 5\%$; NOTE 1	1.8			V
			$V_{DDO} = 1.8V \pm 0.2V; NOTE 1$	V _{DD} - 0.3			V
			$V_{DDO} = 3.3V \pm 5\%$; NOTE 1			0.5	V
V _{OL} Output Low Volta			$V_{DDO} = 2.5V \pm 5\%$; NOTE 1			0.45	V
			$V_{DDO} = 1.8V \pm 0.2V; NOTE 1$			0.35	V

NOTE 1: Outputs terminated with 50Ω to $V_{DDO}/2$. See Parameter Measurement section, "Load Test Circuit" diagrams.

Table 5A. AC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency				250	MHz
tp _{LH}	Propagation Delay, Low to High; NOTE 1			2.5		ns
tp _{HL}	Propagation Delay, High to Low; NOTE 1			2.65		ns
tsk(i)	Input Skew; NOTE 5			45		ps
tsk(pp)	Part-to-Part Skew; NOTE 2, 5			TBD		ps
<i>t</i> jit	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 4	Integration Range: 12KHz - 20MHz		0.07		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%		535		ps
odc	Output Duty Cycle			50		%
t _{EN}	Output Enable Time; NOTE 3				5	ns
t _{DIS}	Output Disable Time; NOTE 3				5	ns
MUX	MUX Isolation	@100MHz		45		dB

NOTE 1A: Measured from $V_{DD}/2$ of the input to $V_{DDO}/2$ of the output. NOTE 2: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at $V_{\rm DDO}/2$.

NOTE 3: These parameters are guaranteed by characterization. Not tested in production.

NOTE 4: Driving only one input clock.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

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Table 5B. AC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency				250	MHz
tp _{LH}	Propagation Delay, Low to High; NOTE 1			2.7		ns
tp _{HL}	Propagation Delay, High to Low; NOTE 1			2.7		ns
tsk(i)	Input Skew; NOTE 5			38		ps
tsk(pp)	Part-to-Part Skew; NOTE 2, 5			TBD		ps
<i>t</i> jit	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 4	Integration Range: 12KHz - 20MHz		0.04		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%		550		ps
odc	Output Duty Cycle			50		%
t _{EN}	Output Enable Time; NOTE 3				5	ns
t _{DIS}	Output Disable Time; NOTE 3				5	ns
MUX	MUX Isolation	@100MHz		45		dB

NOTE 1A: Measured from $V_{DD}/2$ of the input to $V_{DDO}/2$ of the output. NOTE 2: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at V_{DDQ}/2.

NOTE 3: These parameters are guaranteed by characterization. Not tested in production.

NOTE 4: Driving only one input clock.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

Table 5C. AC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $V_{DDO} = 1.8V \pm 0.2V$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency				250	MHz
tp _{LH}	Propagation Delay, Low to High; NOTE 1			3		ns
tp _{HL}	Propagation Delay, High to Low; NOTE 1			3		ns
tsk(i)	Input Skew; NOTE 5			38		ps
tsk(pp)	Part-to-Part Skew; NOTE 2, 5			TBD		ps
<i>t</i> jit	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 4	Integration Range: 12KHz - 20MHz		0.05		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%		595		ps
odc	Output Duty Cycle			50		%
t _{EN}	Output Enable Time; NOTE 3				5	ns
t _{DIS}	Output Disable Time; NOTE 3				5	ns
MUX	MUX Isolation	@100MHz		45		dB

NOTE 1A: Measured from $V_{\rm DD}/2$ of the input to $V_{\rm DDO}/2$ of the output.

NOTE 2: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at $V_{\rm DDO}/2$.

NOTE 3: These parameters are guaranteed by characterization. Not tested in production.

NOTE 4: Driving only one input clock.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

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Table 5D. AC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency				250	MHz
tp _{LH}	Propagation Delay, Low to High; NOTE 1			2.7		ns
tp _{HL}	Propagation Delay, High to Low; NOTE 1			2.9		ns
tsk(i)	Input Skew; NOTE 5			45		ps
tsk(pp)	Part-to-Part Skew; NOTE 2, 5			TBD		ps
<i>t</i> jit	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 4	Integration Range: 12KHz - 20MHz		0.10		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%		540		ps
odc	Output Duty Cycle			50		%
t _{EN}	Output Enable Time; NOTE 3				5	ns
t _{DIS}	Output Disable Time; NOTE 3				5	ns
MUX _{ISOLATION}	MUX Isolation	@100MHz		45		dB

NOTE 1A: Measured from $V_{DD}/2$ of the input to $V_{DDO}/2$ of the output. NOTE 2: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at V_{DDQ}/2.

NOTE 3: These parameters are guaranteed by characterization. Not tested in production.

NOTE 4: Driving only one input clock.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

Table 5E. AC Characteristics, $V_{DD} = 2.5V \pm 5\%$, $V_{DDO} = 1.8V \pm -0.2V$, $TA = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency				250	MHz
tp _{LH}	Propagation Delay, Low to High; NOTE 1			2.9		ns
tp _{HL}	Propagation Delay, High to Low; NOTE 1			3		ns
tsk(i)	Input Skew; NOTE 5			43		ps
tsk(pp)	Part-to-Part Skew; NOTE 2, 5			TBD		ps
<i>t</i> jit	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 4	Integration Range: 12KHz - 20MHz		0.07		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%		590		ps
odc	Output Duty Cycle			50		%
t _{EN}	Output Enable Time; NOTE 3				5	ns
t _{DIS}	Output Disable Time; NOTE 3				5	ns
MUX _{ISOLATION}	MUX Isolation	@100MHz		45		dB

NOTE 1A: Measured from $V_{DD}/2$ of the input to $V_{DDO}/2$ of the output.

NOTE 2: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at $V_{\rm DDO}/2$.

NOTE 3: These parameters are guaranteed by characterization. Not tested in production.

NOTE 4: Driving only one input clock.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

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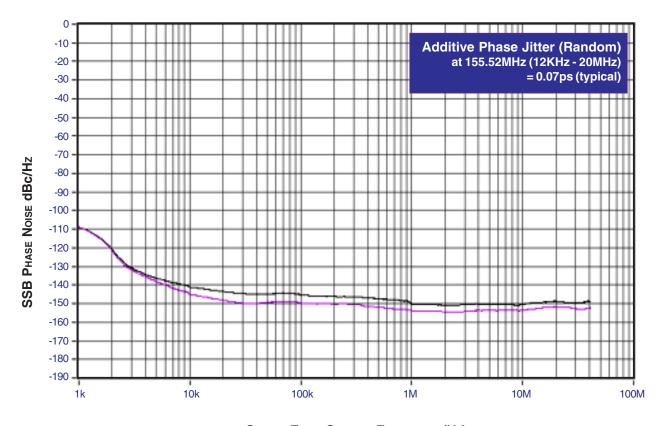




ADDITIVE PHASE JITTER

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the *dBc Phase Noise*. This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio of the power in

the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a **dBc** value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



OFFSET FROM CARRIER FREQUENCY (Hz)

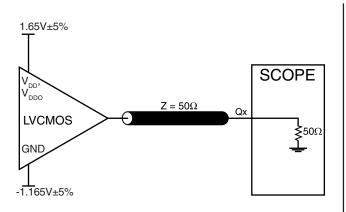
As with most timing specifications, phase noise measurements have issues. The primary issue relates to the limitations of the equipment. Often the noise floor of the equipment is higher than the noise floor of the device. This is illustrated

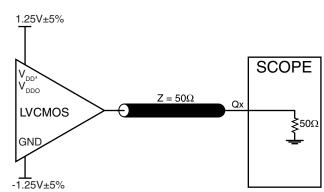
above. The device meets the noise floor of what is shown, but can actually be lower. The phase noise is dependant on the input source and measurement equipment.





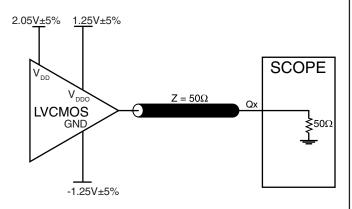
PARAMETER MEASUREMENT INFORMATION

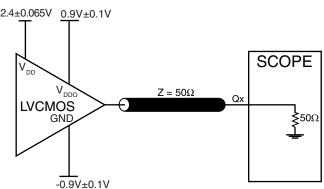




3.3V CORE/3.3V OUTPUT LOAD AC TEST CIRCUIT

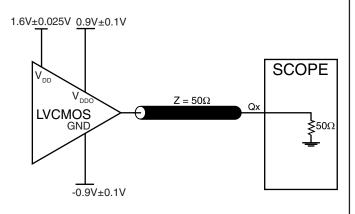
2.5V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT

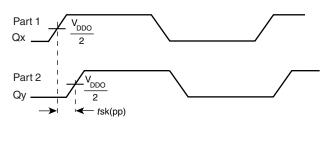




3.3V Core/2.5V OUTPUT LOAD AC TEST CIRCUIT

3.3V CORE/1.8V OUTPUT LOAD AC TEST CIRCUIT





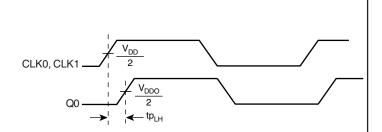
2.5 CORE/1.8V OUTPUT LOAD AC TEST CIRCUIT

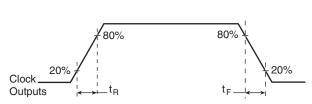
PART-TO-PART SKEW

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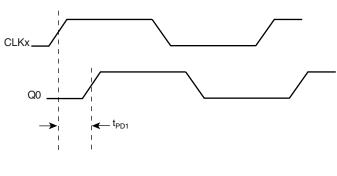
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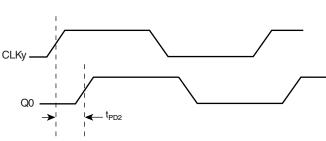




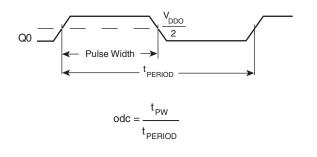


PROPAGATION DELAY





OUTPUT RISE/FALL TIME



INPUT SKEW

OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD



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RELIABILITY INFORMATION

Table 6. $\theta_{\text{JA}} \text{vs. Air Flow Table for 8 Lead TSSOP}$

 θ_{JA} by Velocity (Meters per Second)

 0
 1
 2.5

 Multi-Layer PCB, JEDEC Standard Test Boards
 101.7°C/W
 90.5°C/W
 89.8°C/W

TRANSISTOR COUNT

The transistor count for ICS83052I is: 967



PACKAGE OUTLINE - G SUFFIX FOR 8 LEAD TSSOP

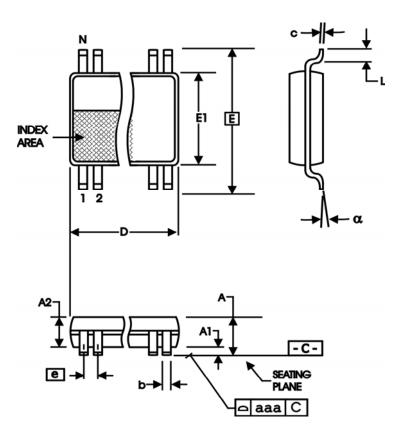


TABLE 7. PACKAGE DIMENSIONS

SYMBOL	Millin	neters
STWBOL	Minimum	Maximum
N	8	8
А		1.20
A1	0.05	0.15
A2	0.80	1.05
b	0.19	0.30
С	0.09	0.20
D	2.90	3.10
E	6.40 E	BASIC
E1	4.30	4.50
е	0.65 E	BASIC
L	0.45	0.75
α	0°	8°
aaa		0.10

Reference Document: JEDEC Publication 95, MO-153



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TABLE 8. ORDERING INFORMATION

Part/Order Number	Marking	Package	Count	Temperature
ICS83052AGI	052AI	8 lead TSSOP	100 per tube	-40°C to 85°C
ICS83052AGIT	052AI	8 lead TSSOP on Tape and Reel	2500	-40°C to 85°C

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